MOSFET - N-Channel, QFET

600 V, 7.4 A, 1.0 Ω

FQB7N60, FQI7N60

Description

This N-Channel enhancement mode power MOSFET is produced using **onsemi**'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on–state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

Features

- 7.4 A, 600 V, $R_{DS(on)} = 1.0 \Omega$ (Max.) @ $V_{GS} = 10 \text{ V}$, $I_D = 3.7 \text{ A}$
- Low Gate Charge (Typ. 29 nC)
- Low Crss (Typ. 16 pF)
- 100% Avalanche Tested
- This Device is Pb-Free, Halide Free and is RoHS Compliant

MAXIMUM RATINGS (T_C = 25°C, unless otherwise noted)

Symbol	Parameter	FQB7N60TM FQI7N60TU	Unit
V _{DSS}	Drain-Source Voltage	600	V
I _D	Drain Current - Continuous (T _C = 25°C)	7.4	Α
	– Continuous ($T_C = 100^{\circ}C$)	4.7	Α
I _{DM}	Drain Current - Pulsed (Note 1)	29.6	Α
V_{GSS}	Gate-Source Voltage	±30	V
E _{AS}	Single Pulsed Avalanche Energy (Note 2)	580	mJ
I _{AR}	Avalanche Current (Note 1)	7.4	Α
E _{AR}	Repetitive Avalanche Energy (Note 1)	14.2	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	4.5	V/ns
P _D	Power Dissipation ($T_A = 25^{\circ}C$) *	3.13	W
	Power Dissipation (T _C = 25°C)	142	W
	– Derate above 25°C	1.14	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range	-55 to +150	°C
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Repetitive rating: pulse-width limited by maximum junction temperature.
- 2. L = 19.5 mH, I_{AS} = 7.4 A, V_{DD} = 50 V, R_{G} = 25 Ω , starting T_{J} = 25°C.
- 3. $I_{SD} \le 7.4 \text{ A}$, $di/dt \le 200 \text{ A/}\mu\text{s}$, $V_{DD} \le BV_{DSS}$, starting $T_J = 25^{\circ}\text{C}$.

V _{DSS}	R _{DS(on)} MAX	I _D MAX
600 V	1.0 Ω @ 10 V	7.4 A





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MARKING

FQB7N60 = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week
G = Pb-Free Package

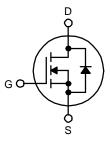


I2PAK (TO-262 3 LD) CASE 418AV &Z&3&K FQI 7N60

&Z = Assembly Plant Code &3 = 3-Digit Date Code

&K = 2-Digits Lot Run Traceability Code

FQI7N60 = Device Code



N-Channel MOSFET

ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

THERMAL CHARACTERISTICS

Symbol	Parameter	FQB7N60TM FQI7N60TU	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case, Max.	0.88	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient (Minimum Pad of 2-oz Copper), Max.	62.5	
	Thermal Resistance, Junction to Ambient (*1 in ² Pad of 2–oz Copper), Max.	40	

ELECTRIC	CAL CHARACTERISTICS (T _C = 25°C unle	ss otherwise noted)				
Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
OFF CHAR	ACTERISTICS					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	600	_	_	V
ΔBV_{DSS} / ΔT_{J}	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, Referenced to 25°C	-	0.67	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 600 V, V _{GS} = 0 V	-	-	10	μΑ
		V _{DS} = 480 V, T _C = 125°C	-	_	100	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V	-	_	100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$	-	_	-100	nA
ON CHARA	CTERISTICS					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	3.0	_	5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 3.7 A	-	0.8	1.0	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = 50 \text{ V}, I_{D} = 3.7 \text{ A}$	_	6.4	_	S
DYNAMIC (CHARACTERISTICS					
C _{iss}	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz	_	1100	1430	pF
C _{oss}	Output Capacitance		-	135	175	pF
C _{rss}	Reverse Transfer Capacitance		_	16	21	pF
SWITCHING	G CHARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	V_{DD} = 300 V, I_{D} = 7.4 A, R_{G} = 25 Ω (Note 4)	_	30	70	ns
t _r	Turn-On Rise Time		_	80	170	ns
t _{d(off)}	Turn-Off Delay Time		_	65	140	ns
t _f	Turn-Off Fall Time		_	60	130	ns
Qg	Total Gate Charge	$V_{DS} = 480 \text{ V}, I_D = 7.4 \text{ A}, V_{GS} = 10 \text{ V}$	-	29	38	nC
Q _{gs}	Gate-Source Charge	(Note 4)	_	7	_	nC
Q_{gd}	Gate-Drain Charge		_	14.5	_	nC
DRAIN-SO	URCE CHARACTERISTICS					
IS	Maximum Continuous Drain-Source Diode Forward Current		_	_	7.4	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forw	ximum Pulsed Drain-Source Diode Forward Current		-	29.6	Α
V_{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 7.4 A	-	-	1.4	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V, } I_{S} = 7.4 \text{ A,}$	-	320	-	ns
Q _{rr}	Reverse Recovery Charge	dl _F / dt = 100 A/μs	_	2.4	-	μС

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Essentially independent of operating temperature.

TYPICAL CHARACTERISTICS

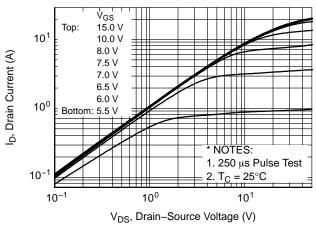


Figure 1. On-Region Characteristics

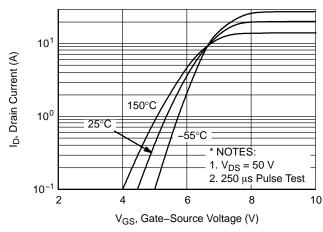


Figure 2. Transfer Characteristics

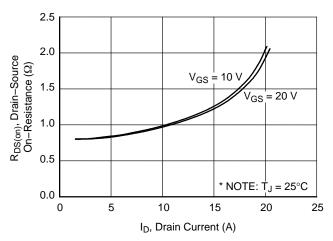


Figure 3. On–Resistance Variation vs. Drain Current and Gate Voltage

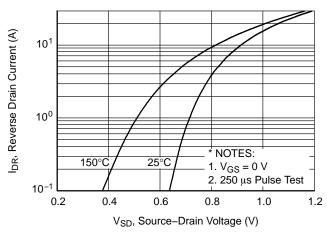


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

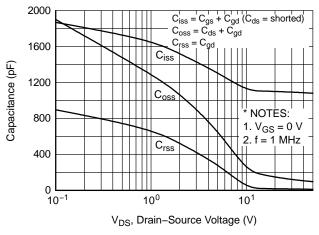


Figure 5. Capacitance Characteristics

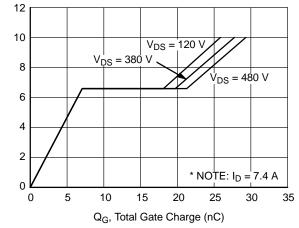
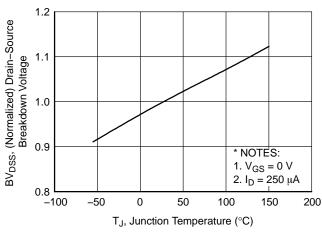


Figure 6. Gate Charge Characteristics

V_{GS}, Gate-Source Voltage (V)

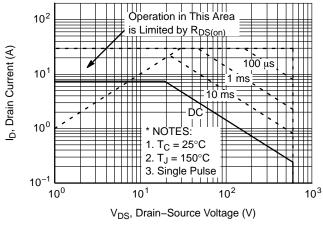
TYPICAL CHARACTERISTICS (CONTINUED)



3.0 R_{DS(on)}, (Normalized) Drain-Source 2.5 On-Resistance 2.0 1.5 1.0 * NOTES: 0.5 1. $V_{GS} = 10 \text{ V}$ 2. $I_D = 3.7 A$ 0.0 -100 50 100 150 200 T_J, Junction Temperature (°C)

Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



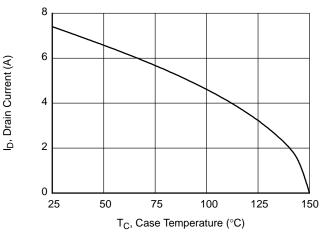


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

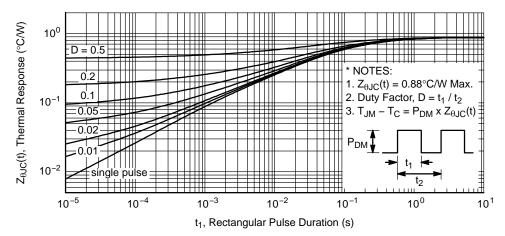


Figure 11. Transient Thermal Response Curve

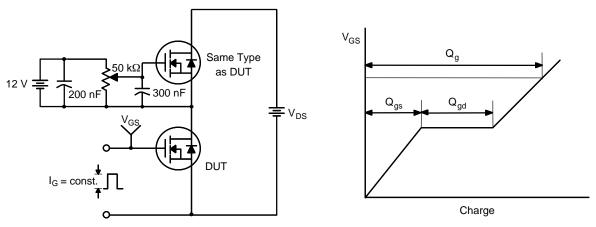


Figure 12. Gate Charge Test Circuit & Waveform

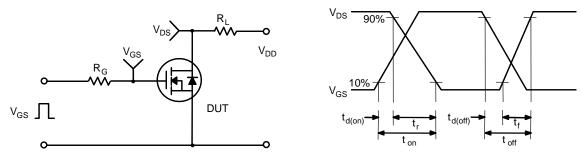


Figure 13. Resistive Switching Test Circuit & Waveforms

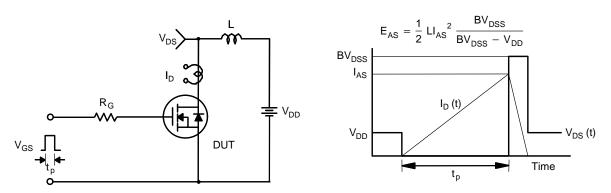
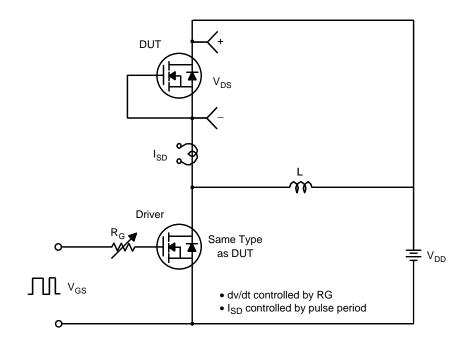


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



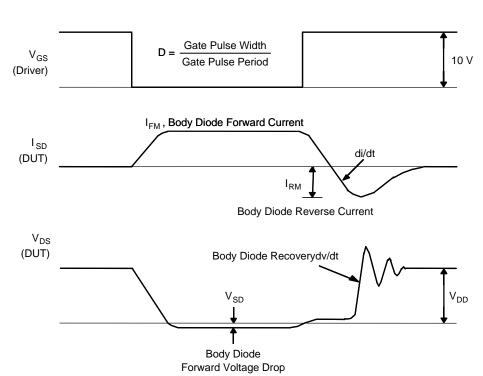


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

ORDERING INFORMATION

Part Number	Top Mark	Package	Reel Size	Tape Width	Shipping [†]
FQB7N60TM	FQB7N60	D ² PAK-3	330 mm	24 mm	800 Units / Tape & Reel
FQI7N60TU	FQI7N60	I2PAK	N/A	N/A	50 Units / Tube

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

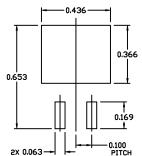




D²PAK-3 (TO-263, 3-LEAD) CASE 418AJ

ISSUE F

DATE 11 MAR 2021



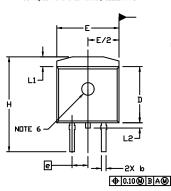
RECOMMENDED
MOUNTING FOOTPRINT

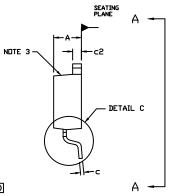
 For additional information on our Pb-Free strategy and soldering details, please downloa the DN Semiconductor Soldering and Mounting Techniques Reference Manual, SDL DERRIV/D.

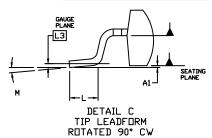
NOTES

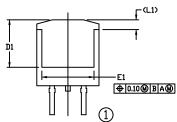
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: INCHES
- 3. CHAMFER OPTIONAL
- I. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.005 PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE DUTERMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
- 5. THERMAL PAD CONTOUR IS OPTIONAL WITHIN DIMENSIONS E, L1, D1, AND E1.
- 6. OPTIONAL MOLD FEATURE.
- 7. ①,② ... OPTIONAL CONSTRUCTION FEATURE CALL DUTS.

	INCHES		MILLIMETERS	
DIM	MIN.	MAX.	MIN.	MAX.
A	0.160	0.190	4.06	4.83
A1	0.000	0.010	0.00	0.25
ھ	0.020	0.039	0.51	0.99
u	0.012	0.029	0.30	0.74
52	0.045	0.065	1.14	1.65
D	0.330	0.380	8.38	9.65
D1	0.260		6.60	
E	0.380	0.420	9.65	10.67
E1	0.245	-	6.22	
e	0.100	BSC	2.54 BSC	
Ξ	0.575	0.625	14.60	15.88
L	0.070	0.110	1.78	2.79
L1		0.066		1.68
L2		0.070		1.78
L3	0.010 BSC		0.25 BSC	
М	0*	8*	0*	8*

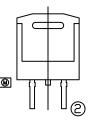


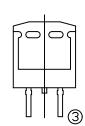


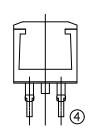




VIEW A-A







VIEW A-A

OPTIONAL CONSTRUCTIONS

XXXXXX = Specific Device Code

A = Assembly Location

WL = Wafer Lot Y = Year

WW = Work Week

W = Week Code (SSG)

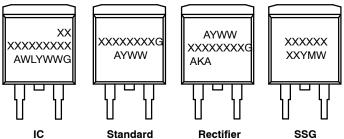
M = Month Code (SSG)

G = Pb-Free Package

AKA = Polarity Indicator

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " •", may or may not be present. Some products may not follow the Generic Marking.

GENERIC MARKING DIAGRAMS*



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DESCRIPTION:

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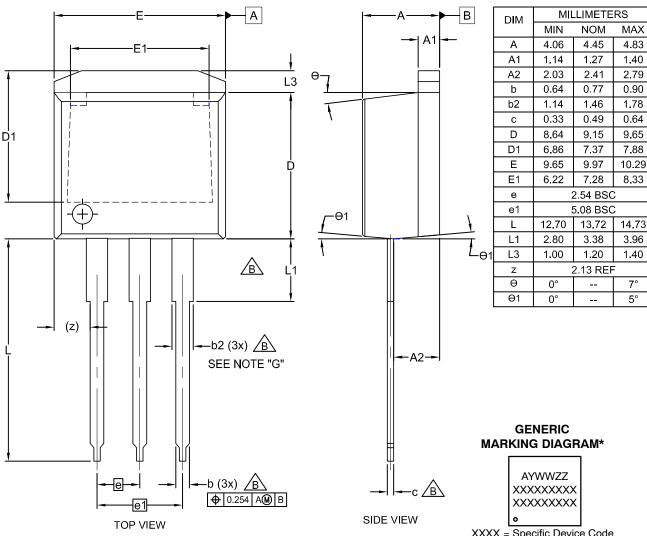
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I2PAK (TO-262 3 LD) CASE 418AV ISSUE A

DATE 30 AUG 2022



NOTES:

A. EXCEPT WHERE NOTED CONFORMS TO TO262 JEDEC VARIATION AA.

- C. ALL DIMENSIONS ARE IN MILLIMETERS.
- D. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.
- E. DIMENSION AND TOLERANCE AS PER ANSI Y14.5-1994.
- F. LOCATION OF PIN HOLE MAY VARY (LOWER LEFT CORNER, LOWER CENTER AND CENTER OF PACKAGE)
- G. MAXIMUM WIDTH FOR F102 DEVICE = 1.35 MAX.

XXXX = Specific Device Code A = Assembly Location

Y = Year
WW = Work Week

ZZ = Assembly Lot Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	I2PAK (TO-262 3 LD)		PAGE 1 OF 1	

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